

FDS6679Z

30 Volt P-Channel PowerTrench^O MOSFET

General Description

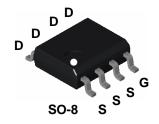
This P-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers, and battery chargers.

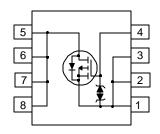
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS(ON)}}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

- -13 A, -30 V. $R_{DS(ON)} = 9 \text{ m}\Omega$ @ $V_{GS} = -10 \text{ V}$ $R_{DS(ON)} = 13 \text{ m}\Omega$ @ $V_{GS} = -4.5 \text{ V}$
- Extended V_{GSS} range (–25V) for battery applications
- ESD protection diode (note 3)
- High performance trench technology for extremely low R_{DS(ON)}
- · High power and current handling capability





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol Parameter Ratings Units V _{DSS} Drain-Source Voltage -30 V V _{GSS} Gate-Source Voltage -25/+20 V Ib Drain Current - Continuous (Note 1a) -13 A - Pulsed -50 -50 W PD Power Dissipation for Single Operation (Note 1a) (Note 1b) (Note 1b) (Note 1b) 1.2 W TJ, T _{STG} Operating and Storage Junction Temperature Range -55 to +175 °C					
VGSS Gate-Source Voltage -25/+20 V Ib Drain Current - Continuous (Note 1a) -13 A - Pulsed -50 Pb Power Dissipation for Single Operation (Note 1a) 2.5 W (Note 1b) 1.2 (Note 1c) 1.0	Symbol	Parameter		Ratings	Units
Drain Current	V _{DSS}	Drain-Source Voltage		-30	V
PD Power Dissipation for Single Operation (Note 1a) (Note 1b) (Note 1c) 1.0 W	V_{GSS}	Gate-Source Voltage		-25/+20	V
Power Dissipation for Single Operation (Note 1a) 2.5 W (Note 1b) 1.2 (Note 1c) 1.0	I D	Drain Current - Continuous	(Note 1a)	-13	A
(Note 1b) 1.2 (Note 1c) 1.0		- Pulsed		-50	
(Note 1c) 1.0	P _D	Power Dissipation for Single Operation	(Note 1a)	2.5	W
, , ,			(Note 1b)	1.2	
T _J , T _{STG} Operating and Storage Junction Temperature Range -55 to +175 °C			(Note 1c)	1.0	
	T _J , T _{STG}	Operating and Storage Junction Temperat	ure Range	-55 to +175	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
R ₀ JC	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

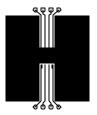
Package Marking and Ordering Information

•	•	,		
Device Marking	Device	Reel Size	Tape width	Quantity
FDS6679Z	FDS6679Z	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			I	ı	I
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		-22		mV/°C
l _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V}, \ V_{GS} = 0 \text{ V}$			-1	μΑ
GSSF	Gate-Body Leakage, Forward	$V_{GS} = -25 \text{ V}, V_{DS} = 0 \text{ V}$			-10	μΑ
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			10	μΑ
On Char	acteristics (Note 2)			•	•	•
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-1	-1.7	-3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		4.9		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = -10 \text{ V}, I_D = -13 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -11 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -13 \text{ A}, T_J = 125 ^{\circ}\text{C}$		7.2 10 10	9 13 13	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	-50			Α
g FS	Forward Transconductance	$V_{DS} = -5 \text{ V}, I_{D} = -13 \text{ A}$		43		S
Dvnamic	Characteristics			I	I	ı
Ciss	Input Capacitance	$V_{DS} = -15 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		3803		pF
Coss	Output Capacitance	f = 1.0 MHz		974		pF
C _{rss}	Reverse Transfer Capacitance	7		490		pF
Switchin	g Characteristics (Note 2)					•
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -15 \text{ V}, I_D = -1 \text{ A},$		18	32	ns
t _r	Turn-On Rise Time	$V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$		9	18	ns
t _{d(off)}	Turn-Off Delay Time	1		92	147	ns
t _f	Turn-Off Fall Time	7		54	86	ns
Qg	Total Gate Charge	$V_{DS} = -15 \text{ V}, I_{D} = -13 \text{ A},$		67	94	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V		11		nC
Q _{gd}	Gate-Drain Charge	1		15		nC
Drain-So	ource Diode Characteristics a	and Maximum Ratings		ı	ı	ı
ls	Maximum Continuous Drain-Source I				-2.1	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -2.1 \text{ A} \text{(Note 2)}$		-0.7	-1.2	V

Notes

R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{8JC} is guaranteed by design while R_{8CA} is determined by the user's board design.



a) 50°C/W (10 sec)
62.5°C/W steady state
when mounted on a
1in² pad of 2 oz
copper



b) 105°C/W when mounted on a .04 in² pad of 2 oz copper



c) 125°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

- **2.** Pulse Test: Pulse Width < 300μ s, Duty Cycle < 2.0%
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics

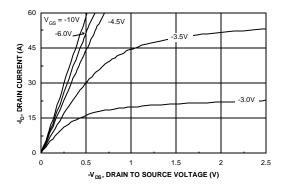


Figure 1. On-Region Characteristics.

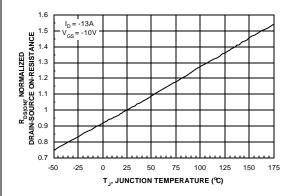


Figure 3. On-Resistance Variation with Temperature.

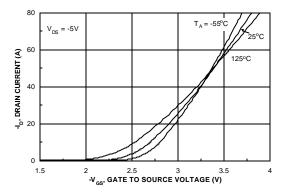


Figure 5. Transfer Characteristics.

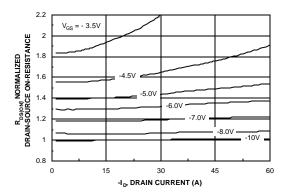


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

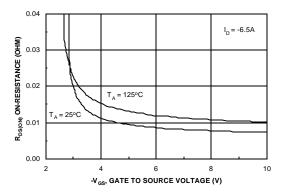


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

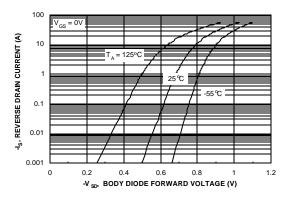
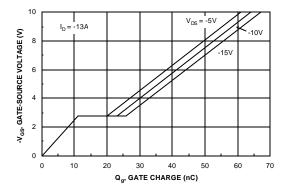


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



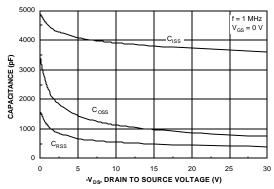
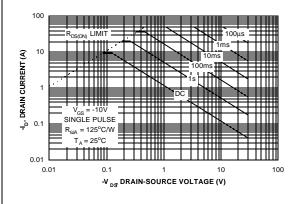


Figure 7. Gate Charge Characteristics.





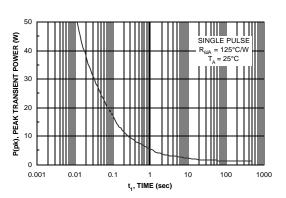


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

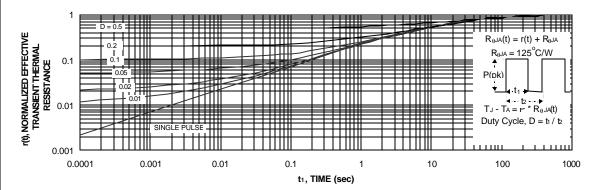
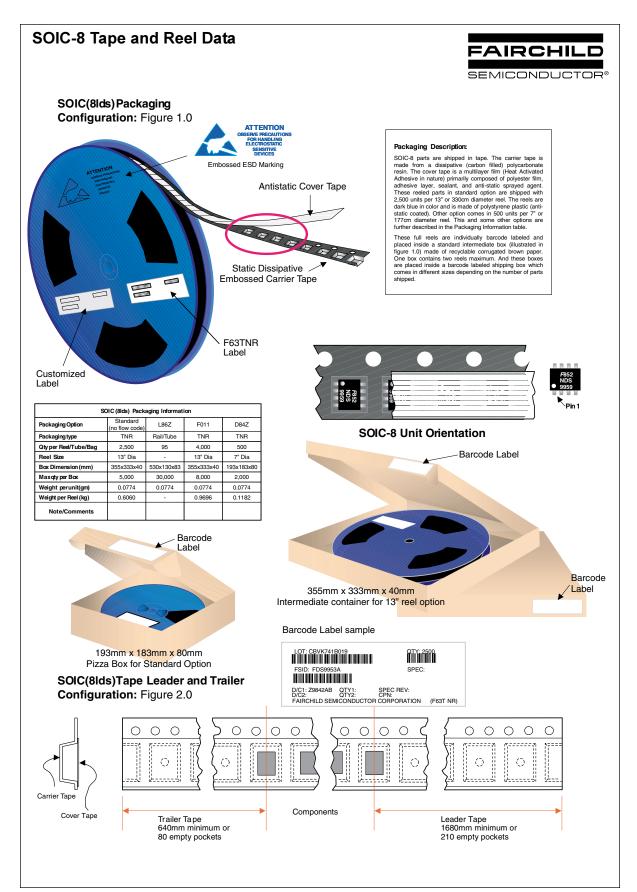


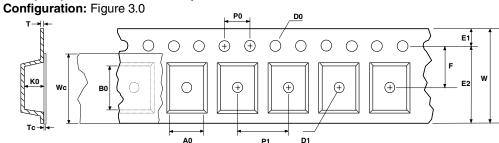
Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.





SOIC(8lds) Embossed Carrier Tape



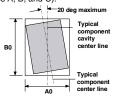


	Dimensions are in millimeter													
Pkg type	Α0	В0	w	D0	D1	E1	E2	F	P1	P0	КО	т	Wc	Тс
SOIC(8lds) (12mm)	5.30 +/-0.10	6.50 +/-0.10	12.0 +/-0.3	1.55 +/-0.05	1.60 +/-0.10	1.75 +/-0.10	10.25 min	5.50 +/-0.05	8.0 +/-0.1	4.0 +/-0.1	2.1 +/-0.10	0.450 +/- 0.150	9.2 +/-0.3	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation



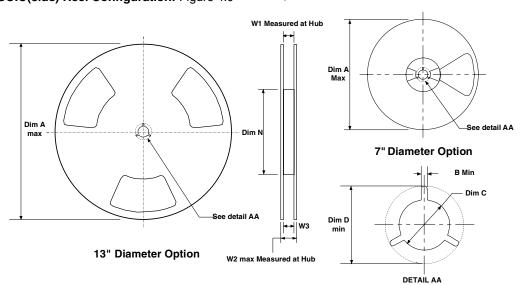
Sketch B (Top View)
Component Rotation



Sketch C (Top View)

Component lateral movement

SOIC(8lds) Reel Configuration: Figure 4.0

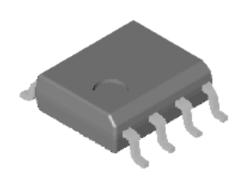


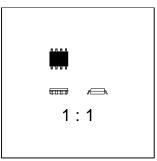
Dimensions are in inches and millimeters									
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)
12mm	7" Dia	7.00 177.8	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	2.165 55	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4
12mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	7.00 178	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4

SOIC-8 Package Dimensions



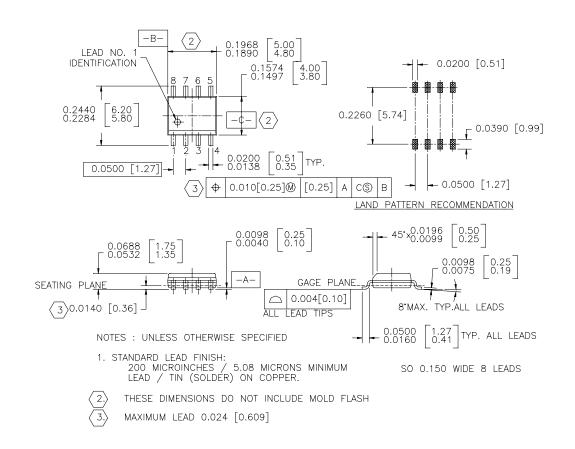
SOIC-8 (FS PKG Code S1)





Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 0.0774



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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.				
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